



P3M12017K4 SiC MOS N-Channel Enhancement Mode

V_{RRM}	= 1200	V
I_D	= 154	A
$I_D(100^\circ\text{C})$	= 109	A
$R_{DS(on)}$	= 17	$\text{m}\Omega$

SiC MOS P3M12017K4 N-Channel Enhancement Mode

Features

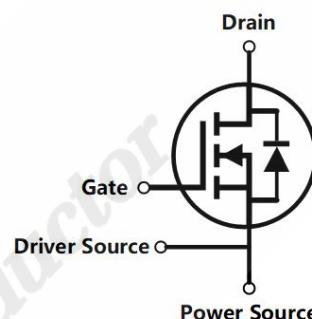
- High Blocking Voltage with Low On-Resistance
- High-Frequency Operation
- Ultra-Small Q_{gd}
- 100% UIS tested

Standards Benefits

- Improve System Efficiency
- Increase Power Density
- Reduce Heat Sink Requirements
- Reduction of System Cost

Application

- Solar Inverters
- EV Battery Chargers
- High Voltage DC/DC Converters
- Switch Mode Power Supplies



TO-247-4

Drain	1
Power Source	2
Driver Source	3
Gate	4



Order Information

Part number	Package	Marking
P3M12017K4	TO-247-4	P3M12017K4



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1. Maximum Ratings

At $T_J = 25^\circ\text{C}$, unless specified otherwise

Parameter	Symbol	Value	Unit	Test Conditions
Drain - Source Voltage	$V_{DS\max}$	1200	V	$V_{GS} = 0\text{V}$ $I_D = 100\mu\text{A}$
Gate - Source Voltage (Dynamic)	$V_{GS\max}$	-8 / +21	V	AC ($f > 1\text{Hz}$)
Gate - Source Voltage (Static)	V_{GSop}	-3 / +15	V	Static
Continuous Drain Current	I_D	154	A	$V_{GS} = 15\text{V}$ $T_C = 25^\circ\text{C}$
		109		$V_{GS} = 15\text{V}$ $T_C = 100^\circ\text{C}$
Pulsed Drain Current	$I_{D(\text{pulse})}$	270	A	
Power Dissipation	P_D	789	W	
Operating Junction Temperature	T_J	-55 To +175	°C	
Storage Temperature	T_{stg}	-55 To +175	°C	
Solder Temperature	T_L	260	°C	
Mounting Torque	M_d	1 8.8	Nm lbf-in	M3 or 6-32 screw



2. Electrical Characteristics

At $T_J = 25^\circ\text{C}$, unless specified otherwise

Parameter	Symbol	Value			Unit	Test Conditions
		Min.	Typ	Max.		
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	1200	/	/	V	$V_{GS} = 0\text{V}$ $I_D = 100\mu\text{A}$
Gate Threshold Voltage	$V_{GS(\text{th})}$	1.8	2.6	/	V	$V_{DS} = V_{GS}$ $I_D = 23\text{mA}$ $T_J = 25^\circ\text{C}$
		/	1.9	/	V	$V_{DS} = V_{GS}$ $I_D = 23\text{mA}$ $T_J = 175^\circ\text{C}$
Reverse Bias Drain Current	I_{DSS}	/	1	100	μA	$V_{GS} = 0\text{V}$ $V_{DS} = 1200\text{V}$
Gate-Source Leakage Current	I_{GSS}	/	20	250	nA	$V_{GS} = 15\text{V}$ $V_{DS} = 0\text{V}$
/Drain-Source On-State Resistance	$R_{DS(\text{on})}$	/	17	23	$\text{m}\Omega$	$V_{GS} = 15\text{V}$ $I_D = 75\text{A}$ $T_J = 25^\circ\text{C}$
		/	17	/	$\text{m}\Omega$	$V_{GS} = 15\text{V}$ $I_D = 75\text{A}$ $T_J = 125^\circ\text{C}$
		/	20	/	$\text{m}\Omega$	$V_{GS} = 15\text{V}$ $I_D = 75\text{A}$ $T_J = 175^\circ\text{C}$
Trans conductance	g_{fs}	/	48	/	S	$V_{DS} = 20\text{V}$ $I_{DS} = 75\text{A}$ $T_J = 25^\circ\text{C}$
		/	47	/	S	$V_{DS} = 20\text{V}$ $I_{DS} = 75\text{A}$ $T_J = 175^\circ\text{C}$



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Parameter	Symbol	Value			Unit	Test Conditions	
		Min.	Typ	Max.			
Input Capacitance	C _{iss}	/	7330	/	pF	V _{GS} = 0V V _{DS} = 800V f= 250kHz V _{AC} = 25mV	
Output Capacitance	C _{oss}	/	282	/	pF		
Reverse Transfer Capacitance	C _{rss}	/	21	/	pF		
Cross Stored Energy	E _{oss}	/	216	/	μJ		
Turn-on Energy	E _{on}	/	2062	/	μJ	V _{DS} = 800V V _{GS} = -3/15V I _{DS} = 75A R _G = 1Ω	
Turn-off Energy	E _{off}	/	1114	/			
Turn-On Delay Time	T _{d(on)}	/	19	/	ns		
Rise Time	T _r	/	62	/			
Turn-Off Delay Time	T _{d(off)}	/	78	/			
Fall Time	T _f	/	30	/			
Internal Gate Resistance	R _{G(int)}	/	4.3	/	Ω	f= 1MHz V _{AC} = 25mV	
Gate to Source Charge	Q _{gs}	/	102	/	nC	V _{DS} = 800V I _{DS} = 75A V _{GS} = 0 to 15V I _G = 50mA	
Gate to Drain Charge	Q _{gd}	/	62	/			
Total Gate Charge	Q _g	/	213	/			



3. Reverse Diode Characteristics

At $T_J = 25^\circ\text{C}$, unless specified otherwise

Parameter	Symbol	Value		Unit	Test Conditions
		Typ.	Max.		
Diode Forward Voltage	V_{SD}	4.8	/	V	$V_{GS} = -3\text{V}$ $I_{SD} = 37.5\text{A}$ $T_J = 25^\circ\text{C}$
		5.1	/	V	$V_{GS} = -3\text{V}$ $I_{SD} = 37.5\text{A}$ $T_J = 175^\circ\text{C}$
Continuous Diode Forward Current	I_S	131	/	A	$V_{GS} = -3\text{V}$
Reverse Recover Time	t_{rr}	25	/	ns	$V_{GS} = -3/15\text{V}$ $I_{SD} = 75\text{A}$ $V_R = 800\text{V}$ $d_i/d_t = 4800\text{A}/\mu\text{s}$ $T_J = 25^\circ\text{C}$
Reverse Recovery Charge	Q_{rr}	521	/	nC	
Peak Reverse Recovery Current	I_{rrm}	35	/	A	

4. Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance from Junction to Case	$R_{\theta JC}$	0.19	°C/W



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5. Typical Performance

At $T_J = 25^\circ\text{C}$, unless specified otherwise

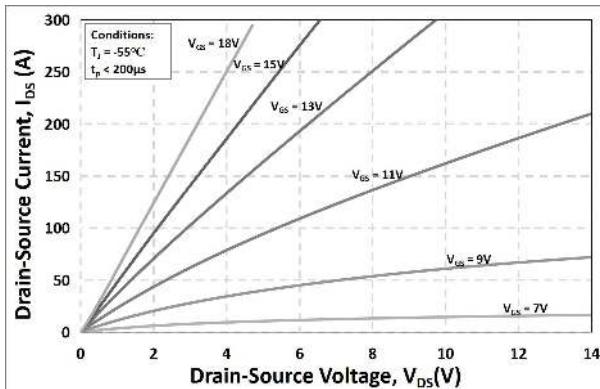


Figure 1. Output Characteristics $T_J = -55^\circ\text{C}$

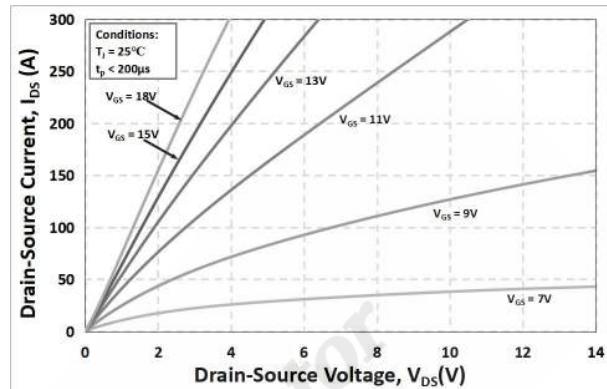


Figure 2. Output Characteristics $T_J = 25^\circ\text{C}$

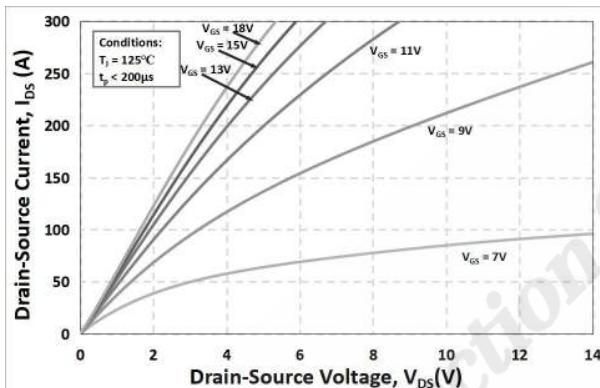


Figure 3. Output Characteristics $T_J = 125^\circ\text{C}$

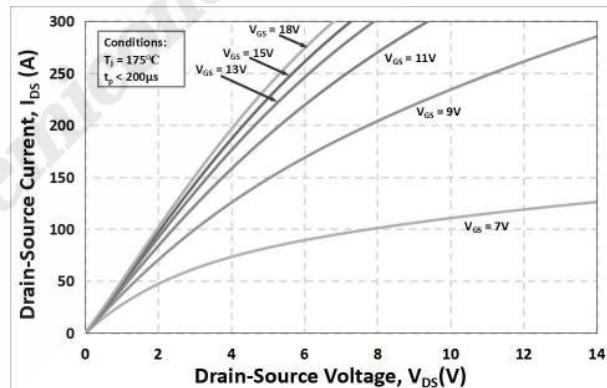


Figure 4. Output Characteristics $T_J = 175^\circ\text{C}$

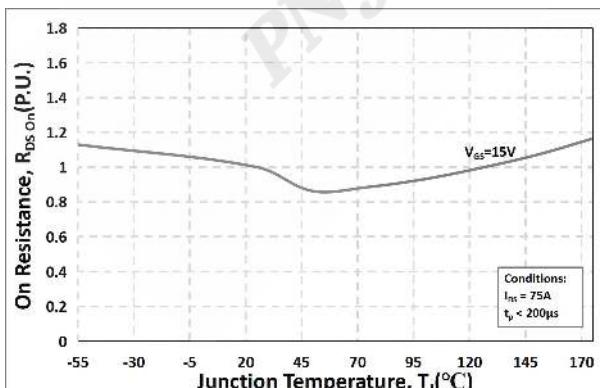


Figure 5. Normalized On-Resistance vs. Temperature

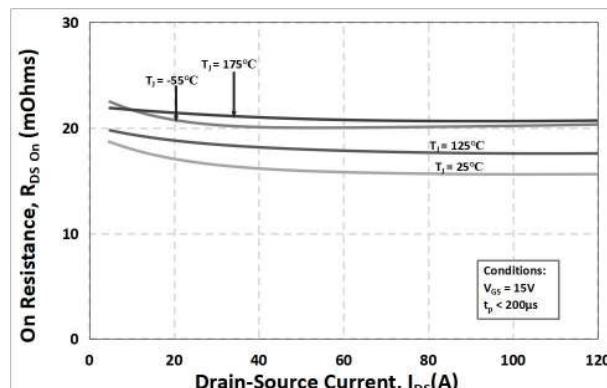


Figure 6. On-Resistance vs. Drain Current Various Temperatures



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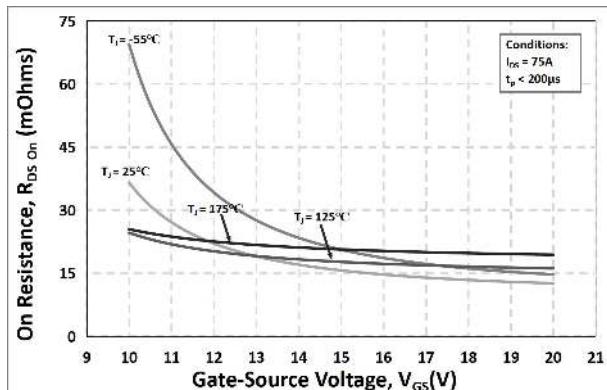


Figure 7. On-Resistance vs. Gate-Source Voltage

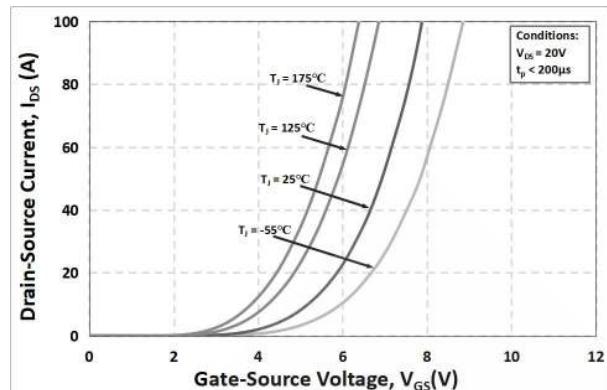


Figure 8. Transfer Characteristic for Various Junction Temperatures

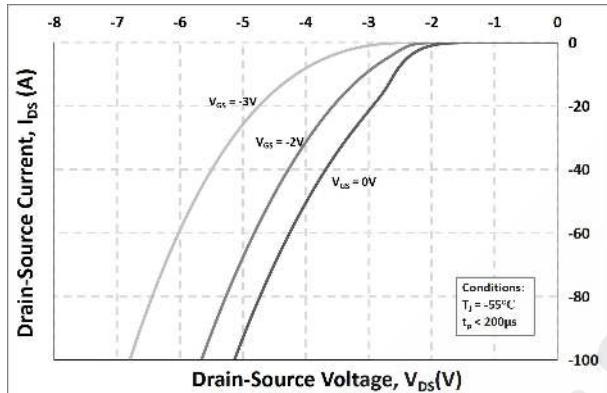


Figure 9. Body Diode Characteristic at -55°C

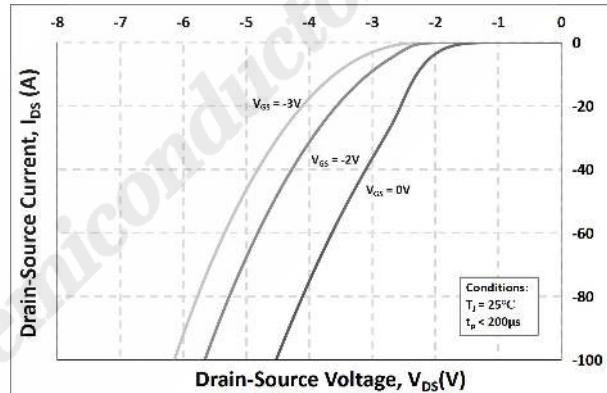


Figure 10. Body Diode Characteristic at 25°C

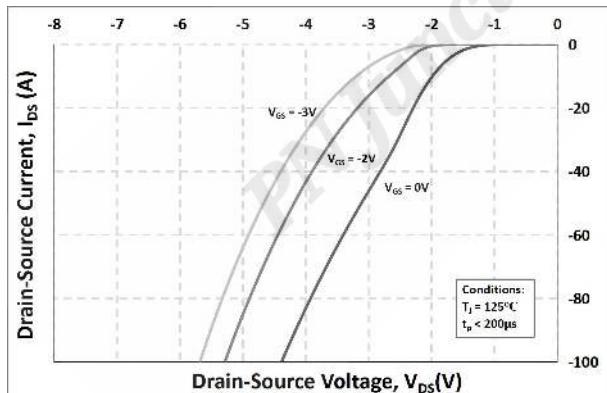


Figure 11. Body Diode Characteristic at 125°C

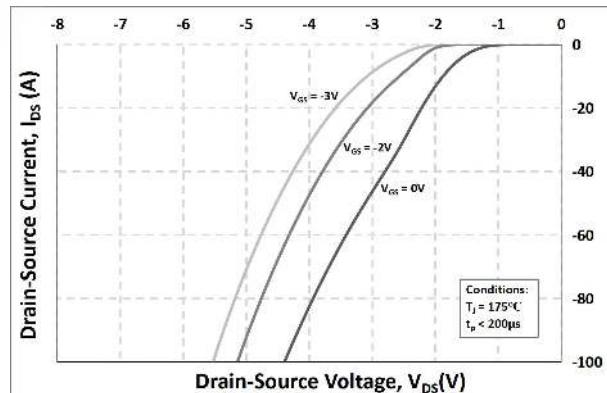


Figure 12. Body Diode Characteristic at 175°C



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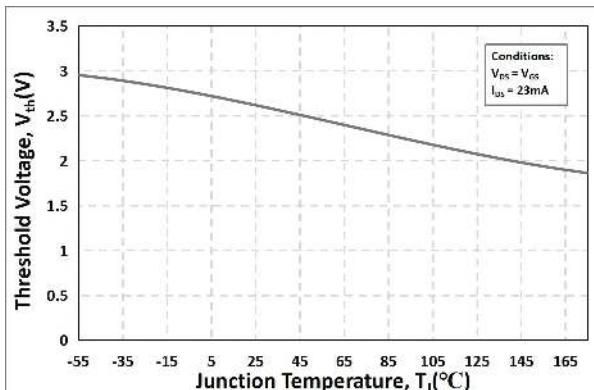


Figure 13. Threshold Voltage vs. Temperature

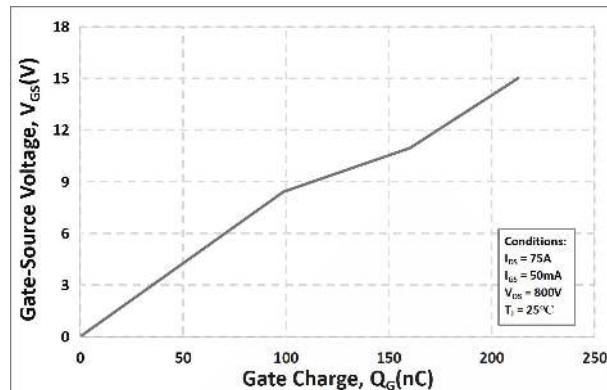


Figure 14. Gate Charge Characteristics

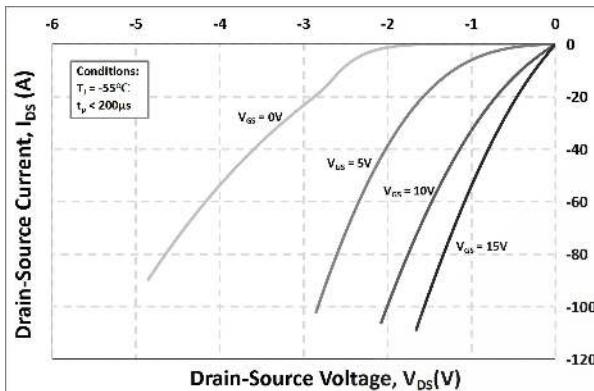


Figure 15. 3rd Quadrant Characteristic at -55°C

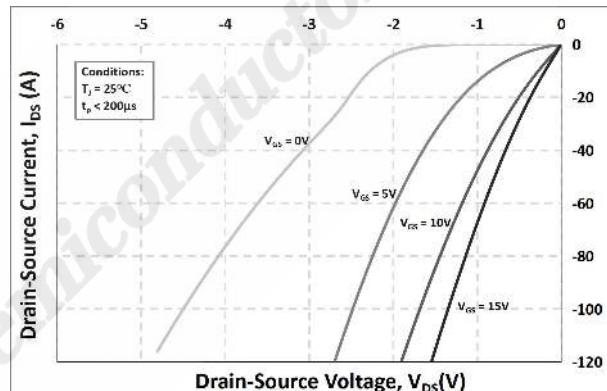


Figure 16. 3rd Quadrant Characteristic at 25°C

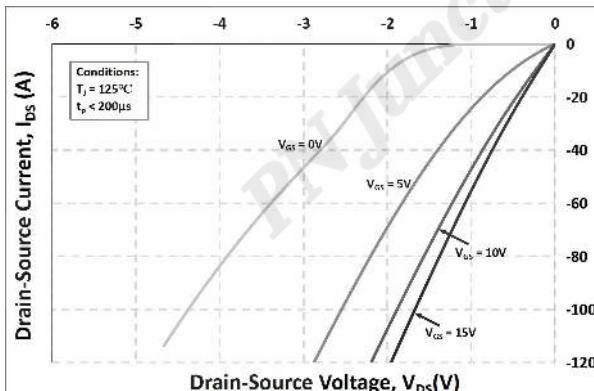


Figure 17. 3rd Quadrant Characteristic at 125°C

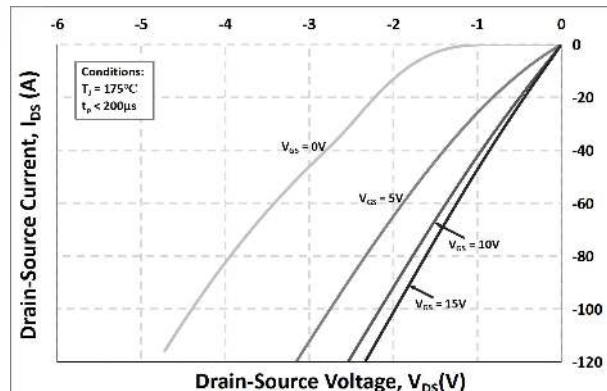


Figure 18. 3rd Quadrant Characteristic at 175°C



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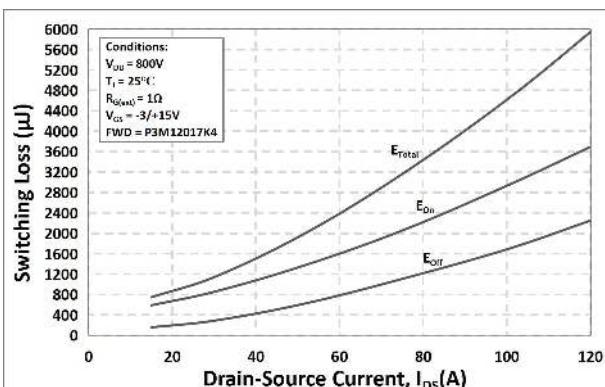


Figure 19. Clamped Inductive Switching Energy vs.
Drain Current ($V_{DD}=800V$)

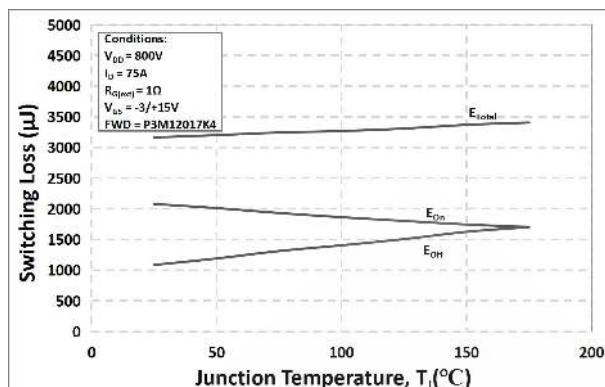


Figure 20. Clamped Inductive Switching Energy vs.
 $R_{G(ext)}$

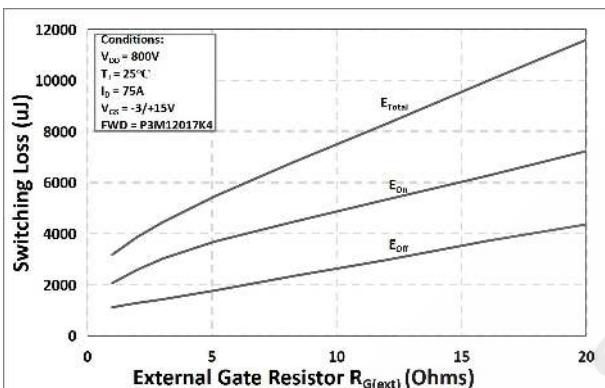


Figure 21. Clamped Inductive Switching Energy vs.
Temperature

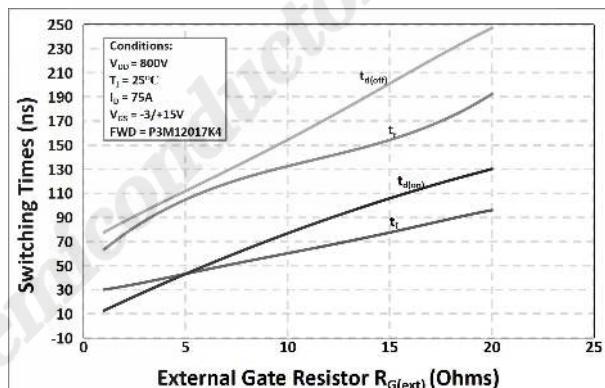


Figure 22. Switching Times vs. $R_{G(ext)}$

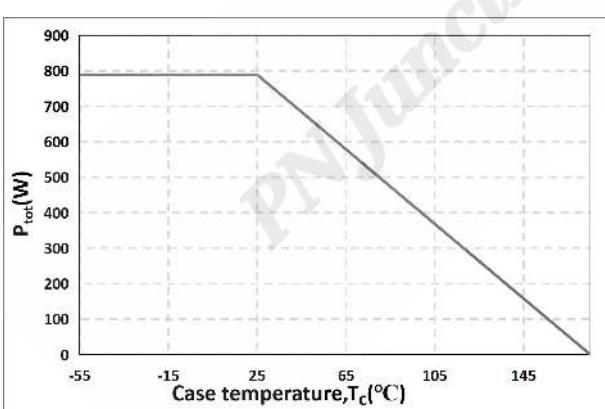


Figure 23. Maximum Power Dissipation Derating vs.
Case Temperature

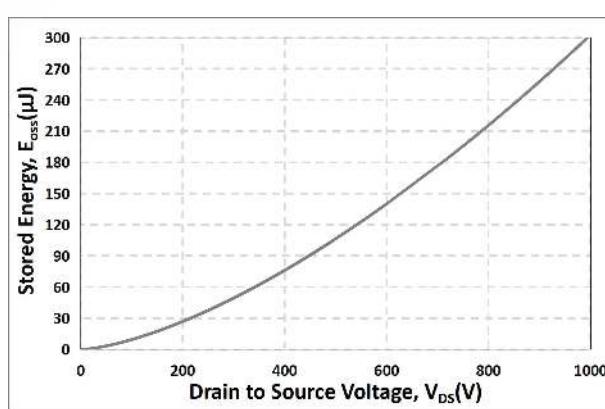


Figure 24. Output Capacitor Stored Energy



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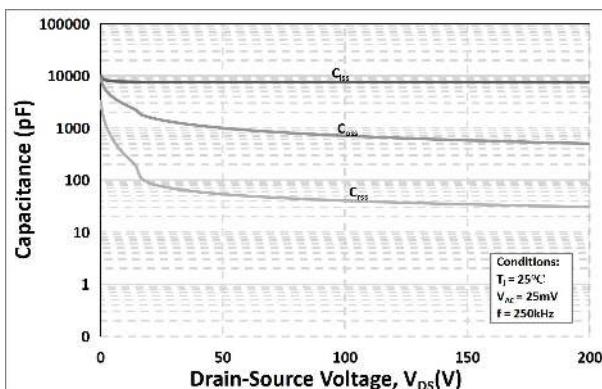


Figure 25. Capacitances vs. Drain-Source Voltage (0 - 200V)

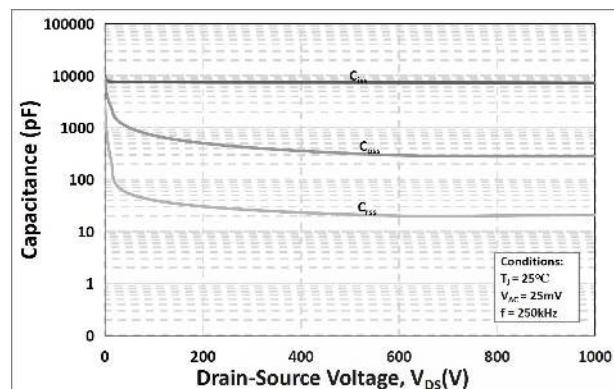


Figure 26. Capacitances vs. Drain-Source Voltage (0 - 1000V)

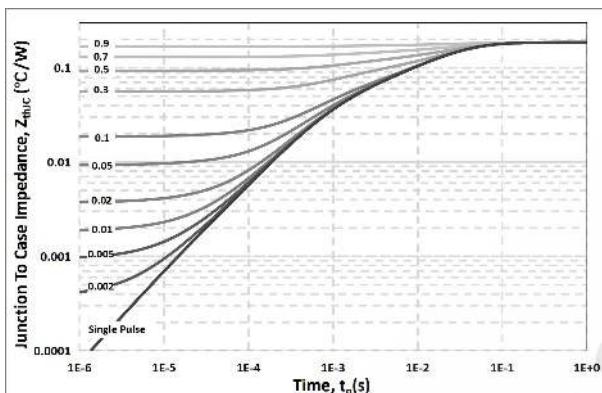


Figure 27. Transient Thermal Impedance (Junction - Case)

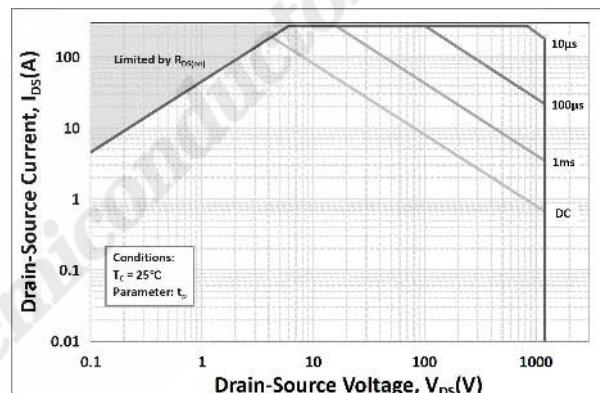
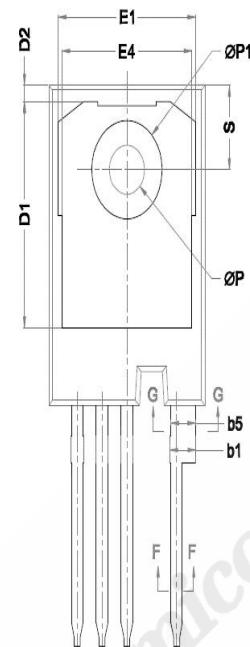
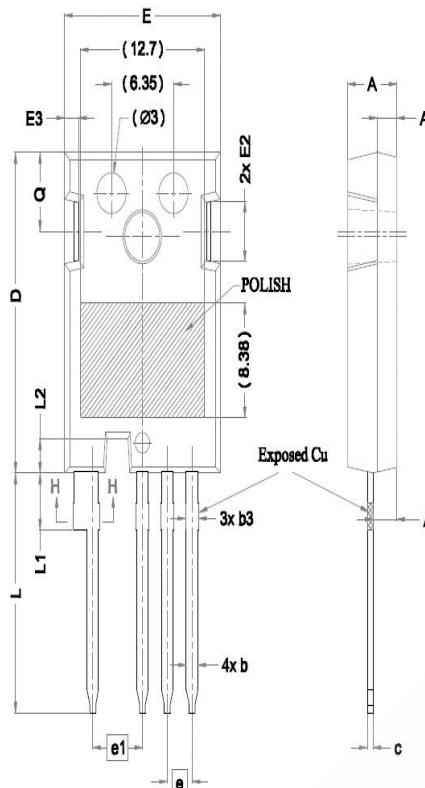


Figure 28. Safe Operating Area



6. Package Outlines



Symbol	Dimensions		
	Min.	Nom.	Max.
A	4.83	5.02	5.21
A1	2.28	2.41	2.54
A2	1.91	2.00	2.16
b ¹	1.07	1.20	1.28
b	1.07	1.20	1.33
b1	2.39	2.67	2.94
b2	2.39	2.67	2.84
b3	1.07	1.30	1.60
b4	1.07	1.30	1.50
b5	2.39	2.53	2.69
b6	2.39	2.53	2.64
c	0.55	0.60	0.68
c1	0.55	0.60	0.65
D	22.30	23.45	23.80
D1	16.25	16.55	17.65
D2	0.95	1.19	1.25
E	15.75	15.94	16.13
E1	13.10	14.02	14.15
E2	3.60	1.10	5.10
E3	1.00	1.45	1.90
E4	12.38	13.26	13.43
e	2.54BSC		
c1	5.08BSC		
L	17.31	17.57	17.82
L1	3.97	4.19	4.37
L2	2.35	2.50	2.65
ØP	3.51	3.61	3.65
ØP	7.19 REF.		
Q	5.49	5.79	6.00
S	6.04	6.17	6.30

Drawing and dimensions



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